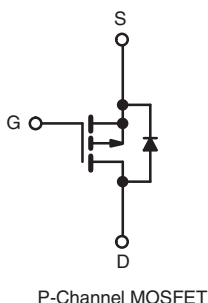
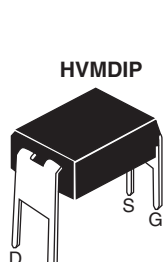


## Power MOSFET

### PRODUCT SUMMARY

$V_{DS}$ (V)	- 100	
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = - 10$ V	0.60
$Q_g$ (Max.) (nC)	18	
$Q_{gs}$ (nC)	3.0	
$Q_{gd}$ (nC)	9.0	
Configuration	Single	



### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



**RoHS\***  
COMPLIANT

### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

### ORDERING INFORMATION

Package	HVMDIP
Lead (Pb)-free	IRFD9120PbF SiHFD9120-E3
SnPb	IRFD9120 SiHFD9120

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C, unless otherwise noted)

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	- 100	V
Gate-Source Voltage			$V_{GS}$	$\pm$ 20	
Continuous Drain Current	$V_{GS}$ at - 10 V	$T_A = 25\text{ }^{\circ}\text{C}$	$I_D$	- 1.0	A
		$T_A = 100\text{ }^{\circ}\text{C}$		- 0.70	
Pulsed Drain Current <sup>a</sup>			$I_{DM}$	- 8.0	
Linear Derating Factor				0.0083	W/ $^{\circ}\text{C}$
Single Pulse Avalanche Energy <sup>b</sup>			$E_{AS}$	140	mJ
Repetitive Avalanche Current <sup>a</sup>			$I_{AR}$	- 1.0	A
Repetitive Avalanche Energy <sup>a</sup>			$E_{AR}$	0.13	mJ
Maximum Power Dissipation	$T_A = 25\text{ }^{\circ}\text{C}$		$P_D$	1.3	W
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	- 5.5	V/ns
Operating Junction and Storage Temperature Range			$T_J, T_{stg}$	- 55 to + 175	$^{\circ}\text{C}$
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	

#### Notes



- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = - 25$  V, starting  $T_J = 25$  °C,  $L = 52$  mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = - 2.0$  A (see fig. 12).
- $I_{SD} \leq - 6.8$  A,  $dI/dt \leq 110$  A/ $\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 175$  °C.
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

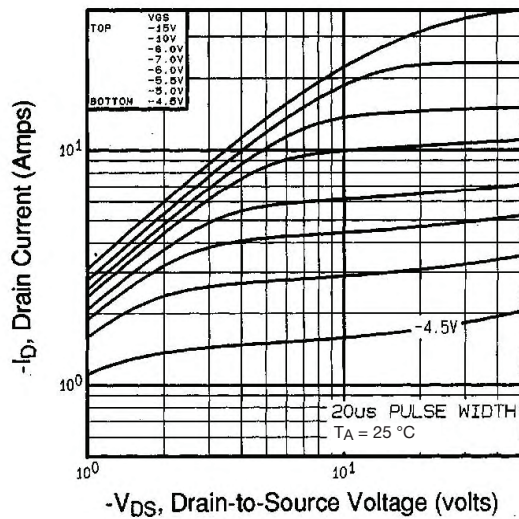
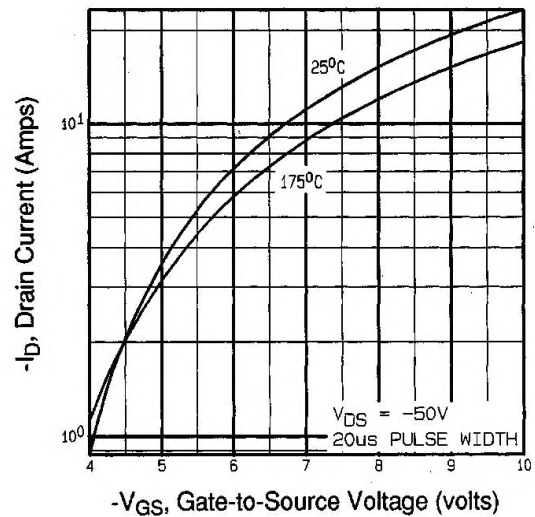
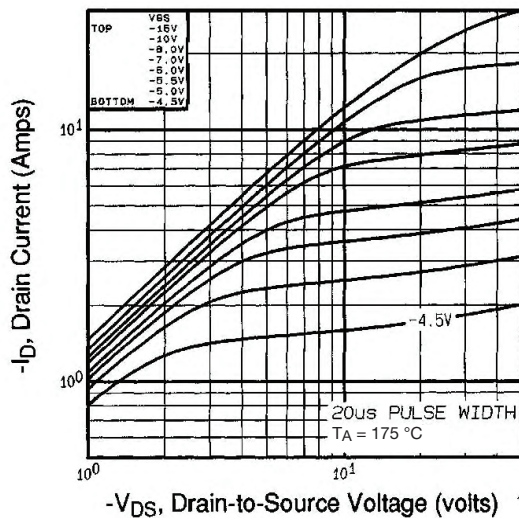
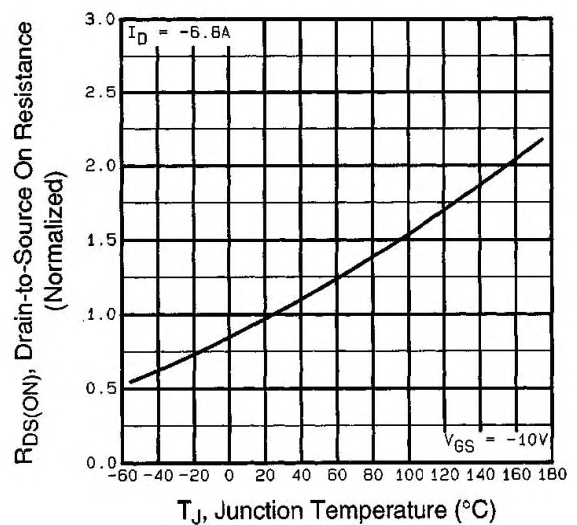
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	120	°C/W

**SPECIFICATIONS** ( $T_J = 25\text{ °C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = - 1 mA		-	- 0.10	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA		- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V		-	-	- 100	μA
		V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	-	- 500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 0.6 A <sup>b</sup>	-	-	0.60	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = - 50 V, I <sub>D</sub> = - 0.60 A <sup>b</sup>		0.71	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V V <sub>DS</sub> = - 25 V f = 1.0 MHz, see fig. 5		-	390	-	pF
Output Capacitance	C <sub>oss</sub>			-	170	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	45	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 6.8 A, V <sub>DS</sub> = - 80 V see fig. 6 and 13 <sup>b</sup>	-	-	18	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	3.0	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	9.0	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = - 50 V, I <sub>D</sub> = - 6.8 A R <sub>g</sub> = 18 Ω, R <sub>D</sub> = 7.1 Ω, see fig. 10 <sup>b</sup>		-	9.6	-	ns
Rise Time	t <sub>r</sub>			-	29	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	21	-	
Fall Time	t <sub>f</sub>			-	25	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact 		-	4.0	-	nH
Internal Source Inductance	L <sub>S</sub>			-	6.0	-	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode 		-	-	- 1.0	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 8.0	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = - 1.0 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	- 6.3	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 6.8 A, dI/dt = 100 A/μs <sup>b</sup>		-	98	200	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.33	0.66	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics,  $T_A = 25^\circ\text{C}$** 

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics,  $T_A = 175^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**

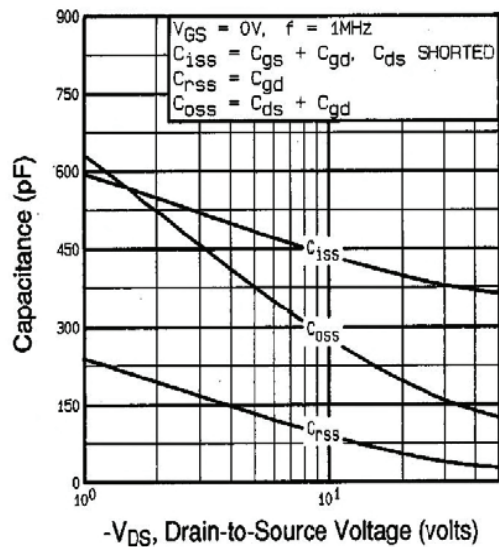


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

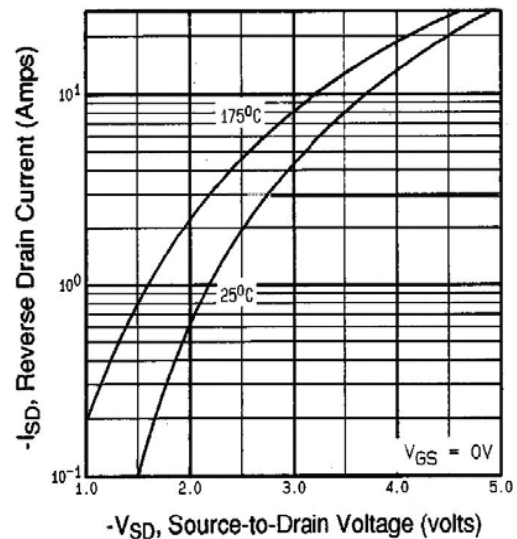


Fig. 7 - Typical Source-Drain Diode Forward Voltage

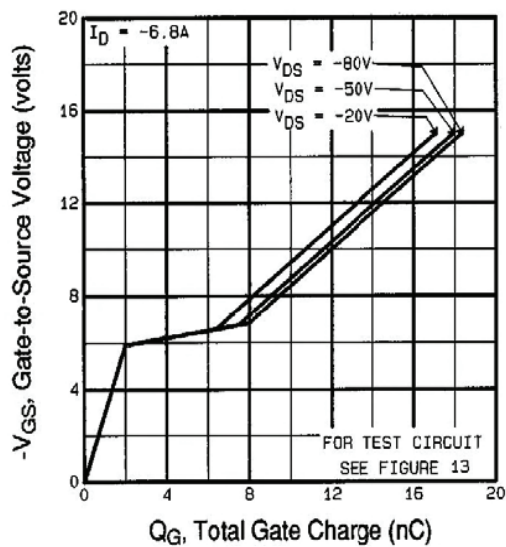


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

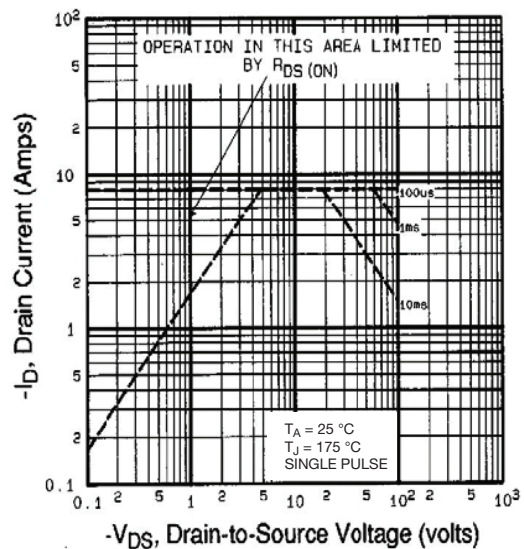


Fig. 8 - Maximum Safe Operating Area

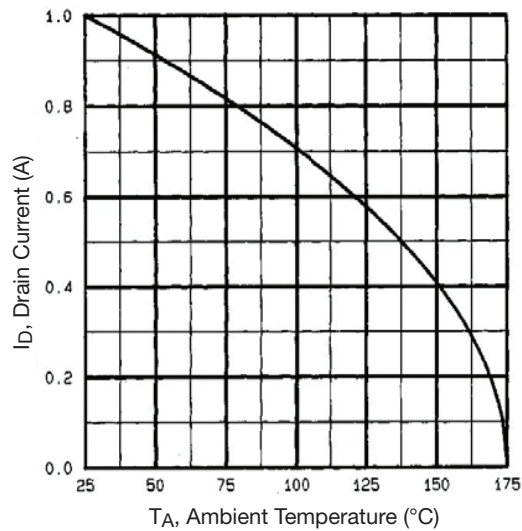


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

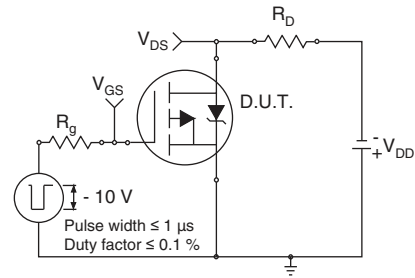


Fig. 10a - Switching Time Test Circuit

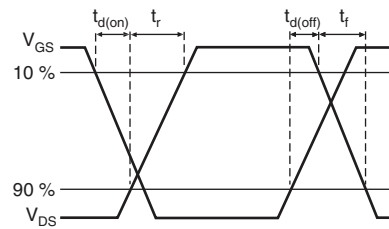


Fig. 10b - Switching Time Waveforms

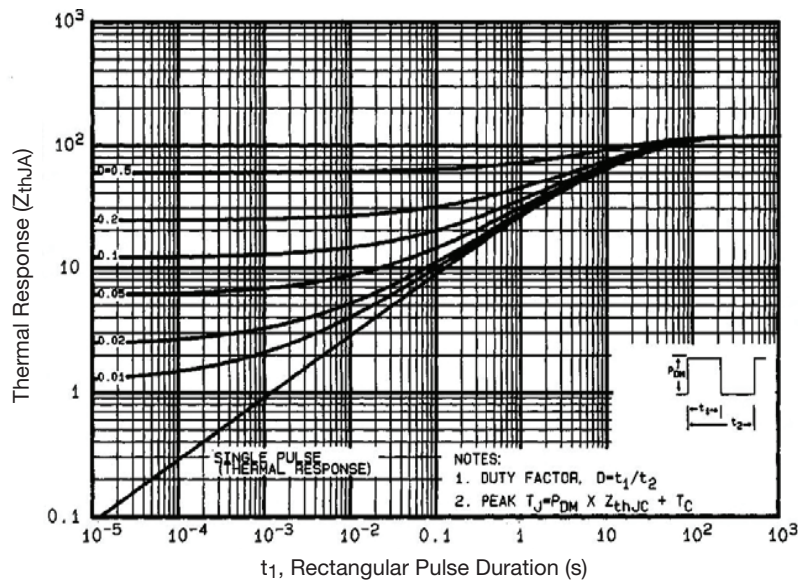


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

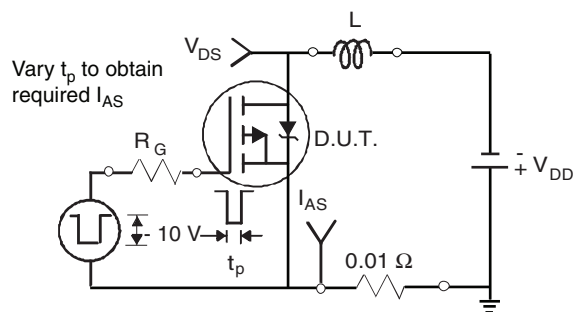


Fig. 12a - Unclamped Inductive Test Circuit

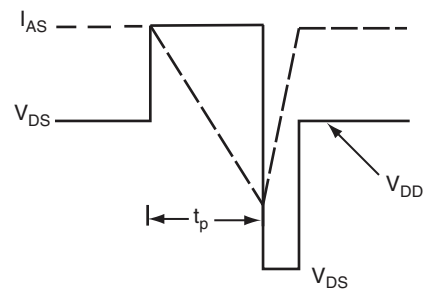


Fig. 12b - Unclamped Inductive Waveforms

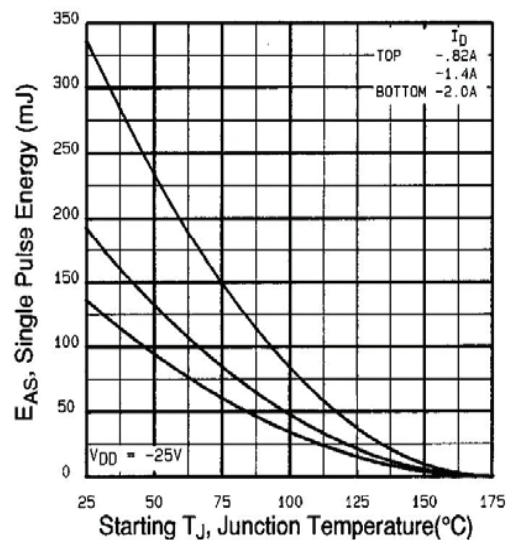


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

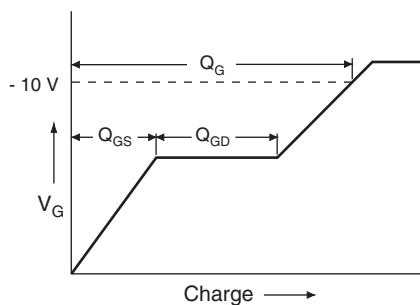


Fig. 13a - Basic Gate Charge Waveform

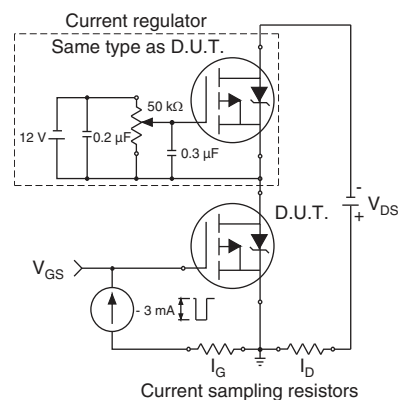
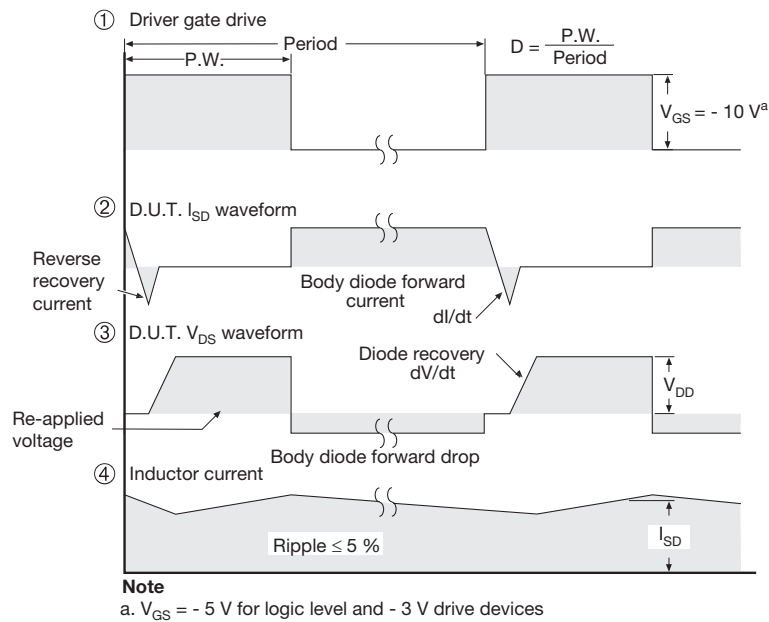
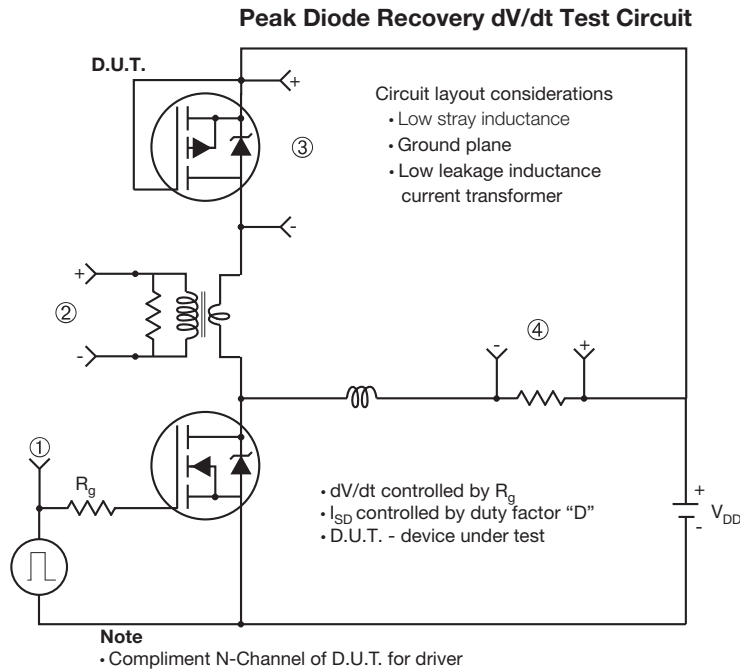


Fig. 13b - Gate Charge Test Circuit





**Fig. 14 - For P-Channel**

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